

8961726 TEXAS INSTR (OPT0)

62C 37077 D

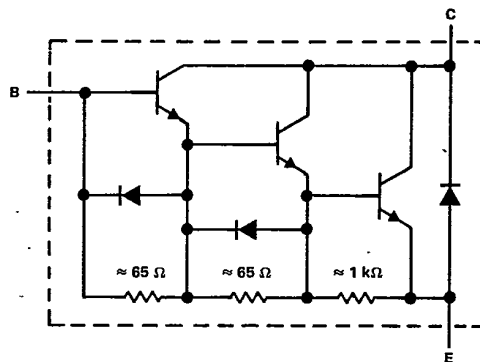
TIPL773, TIPL773A, TIPL773B
N-P-N SILICON TRIPLE TRANSISTOR
ADVANCED POWER DARLINGTONS

REVISED OCTOBER 1984

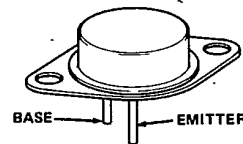
T-33-29

- 180 W at 25°C Case Temperature
- 20 A Continuous Collector Current
- 55 A Peak Collector Current
- Large RBSOA (up to 20 A at 800 V) Permits Snubberless Operation
- All Major Parameters Specified at 100°C

device schematic



TO-3 PACKAGE



THE COLLECTOR IS IN ELECTRICAL
CONTACT WITH THE CASE

absolute maximum ratings at 25°C case temperature (unless otherwise noted)

	TIPL773	TIPL773A	TIPL773B
Collector-base voltage ($I_E = 0$)	950 V	1050 V	1150 V
Collector-emitter voltage ($V_{BE} = 0$)	950 V	1050 V	1150 V
Collector-emitter voltage ($I_B = 0$)	600 V	700 V	800 V
Base-emitter voltage	6 V	6 V	6.5 V
Continuous collector current	20 A		
Peak collector current (see Note 1)	55 A		
Continuous base current	3 A		
Peak parallel diode forward current (see Note 1)	55 A		
Continuous device dissipation at 25°C case temperature (see Figure 27)	180 W		
Operating junction and storage temperature range	-65°C to 200°C		

NOTE 1: This value applies for $t_W \leq 300 \mu s$, duty cycle $\leq 2\%$.

TIPL Devices

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T-33-29**TIPL773**
N-P-N SILICON TRIPLE TRANSISTOR
ADVANCED POWER DARLINGTON

electrical characteristics at 25°C case temperature (unless otherwise noted)

PARAMETER	TEST CONDITIONS	TIPL773			UNIT
		MIN	TYP	MAX	
$V_{CE(sus)}$	$I_C = 6\text{ A}$, $I_{B2} = 1\text{ A}$, See Figures 1 and 1a	710			V
$V_{CE0(sus)}$	$I_C = 0.1\text{ A}$, $L = 25\text{ mH}$, See Note 2	600			V
I_{CEO}	$V_{CE} = 600\text{ V}$, $I_B = 0$			50	μA
I_{CES}	$V_{CE} = 950\text{ V}$, $V_{BE} = 0$			0.1	mA
I_{CEV}	$V_{CE} = 950\text{ V}$, $V_{BE} = 0$, $T_C = 100^\circ\text{C}$			1	mA
I_{EB0}	$V_{CE} = 950\text{ V}$, $V_{BE} = -1.5\text{ V to } -6\text{ V}$			0.1	mA
	$V_{EB} = 6\text{ V}$, $I_C = 0$			10	mA
$V_{CE(sat)}$	$I_C = 3\text{ A}$, $I_B = 60\text{ mA}$, See Notes 3 and 4			2	V
	$I_C = 10\text{ A}$, $I_B = 0.2\text{ A}$, See Notes 3 and 4			2.2	
	$I_C = 15\text{ A}$, $I_B = 0.3\text{ A}$, See Notes 3 and 4			2.5	
	$I_C = 15\text{ A}$, $I_B = 0.3\text{ A}$, $T_C = 100^\circ\text{C}$, See Notes 3 and 4			2.5	
$V_{BE(sat)}$	$I_C = 3\text{ A}$, $I_B = 60\text{ mA}$, See Notes 3 and 4			3	V
	$I_C = 10\text{ A}$, $I_B = 0.2\text{ A}$, See Notes 3 and 4			3.5	
	$I_C = 15\text{ A}$, $I_B = 0.3\text{ A}$, See Notes 3 and 4			4	
	$I_C = 15\text{ A}$, $I_B = 0.3\text{ A}$, $T_C = 100^\circ\text{C}$, See Notes 3 and 4			4	
V_F	$I_F = 15\text{ A}$, See Notes 3 and 4			2	V
h_{FE}	$V_{CE} = 5\text{ V}$, $I_C = 0.5\text{ A}$			50	
C_{obo}	$V_{CB} = 5\text{ V}$, $I_E = 0$, $f = 0.1\text{ MHz}$			185	pF

NOTES: 2. Inductive loop switching measurement.

3. These parameters must be measured using pulse techniques, $t_W \leq 300\text{ }\mu\text{s}$, duty cycle $\leq 2\%$.

4. These parameters are measured with voltage-sensing contacts separate from the current-carrying contacts located within 3.2 mm (0.125 inch) from the device body.

thermal characteristics

PARAMETER	MIN	TYP	MAX	UNIT
$R_{\theta JC}$		0.97		$^\circ\text{C/W}$

resistive-load switching characteristics at 25°C case temperature (unless otherwise noted)

PARAMETER	TEST CONDITIONS	TIPL773			UNIT
		MIN	TYP	MAX	
t_{on}	$I_C = 15\text{ A}$, $V_{CE} = 250\text{ V}$, $I_{B2} = -1.5\text{ A}$, $T_C = 25^\circ\text{C}$, See Figures 1 and 1c		1.25		μs
t_s			3		μs
t_f			1		μs
t_{on}	$I_C = 15\text{ A}$, $V_{CE} = 250\text{ V}$, $I_{B2} = -1.5\text{ A}$, $T_C = 100^\circ\text{C}$, See Figures 1 and 1c		2		μs
t_s			4		μs
t_f			2		μs

inductive-load switching characteristics at 25°C case temperature (unless otherwise noted)

PARAMETER	TEST CONDITIONS	TIPL773			UNIT
		MIN	TYP	MAX	
t_{sv}	$I_C = 15\text{ A}$, $V_{CE} = 300\text{ V}$, $I_{B2} = -1.5\text{ A}$, $T_C = 25^\circ\text{C}$, See Figures 1, 1b, and 2		2.8		μs
t_{rv}			0.5		μs
t_{fl}			0.3		μs
t_{xo}			0.8		μs
t_{tl}			0.1		μs
t_{sv}			4.8		μs
t_{rv}	$I_C = 15\text{ A}$, $V_{CE} = 300\text{ V}$, $I_{B2} = -1.5\text{ A}$, $T_C = 100^\circ\text{C}$, See Figures 1, 1b, and 2		1.5		μs
t_{fl}			0.5		μs
t_{xo}			2		μs
t_{tl}			0.15		μs

TIPL Devices



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TIPL773A
N-P-N SILICON TRIPLE TRANSISTOR
ADVANCED POWER DARLINGTON

electrical characteristics at 25°C case temperature (unless otherwise noted)

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PARAMETER	TEST CONDITIONS	TIPL773A			UNIT
		MIN	TYP	MAX	
$V_{CEX(sus)}$	$I_C = 6\text{ A}$, $I_{B2} = 1\text{ A}$, See Figures 1 and 1a	860			V
$V_{CEO(sus)}$	$I_C = 0.1\text{ A}$, $L = 25\text{ mH}$, See Note 2	700			V
I_{CEO}	$V_{CE} = 700\text{ V}$, $I_B = 0$			50	μA
I_{CES}	$V_{CE} = 1050\text{ V}$, $V_{BE} = 0$			0.1	mA
	$V_{CE} = 1050\text{ V}$, $V_{BE} = 0$, $T_C = 100^\circ\text{C}$			1	
I_{CEV}	$V_{CE} = 1050\text{ V}$, $V_{BE} = -1.5\text{ V to } -6\text{ V}$			0.1	mA
I_{EBO}	$V_{EB} = 6\text{ V}$, $I_C = 0$			10	mA
$V_{CE(sat)}$	$I_C = 2.5\text{ A}$, $I_B = 50\text{ mA}$, See Notes 3 and 4			2	V
	$I_C = 7.5\text{ A}$, $I_B = 0.15\text{ A}$, See Notes 3 and 4			2.2	
	$I_C = 12.5\text{ A}$, $I_B = 0.25\text{ A}$, See Notes 3 and 4			2.5	
	$I_C = 12.5\text{ A}$, $I_B = 0.25\text{ A}$, $T_C = 100^\circ\text{C}$, See Notes 3 and 4			2.5	
$V_{BE(sat)}$	$I_C = 2.5\text{ A}$, $I_B = 50\text{ mA}$, See Notes 3 and 4			3	V
	$I_C = 7.5\text{ A}$, $I_B = 0.15\text{ A}$, See Notes 3 and 4			3.5	
	$I_C = 12.5\text{ A}$, $I_B = 0.25\text{ A}$, See Notes 3 and 4			4	
	$I_C = 12.5\text{ A}$, $I_B = 0.25\text{ A}$, $T_C = 100^\circ\text{C}$, See Notes 3 and 4			4	
V_F	$I_F = 15\text{ A}$, See Notes 3 and 4			2	V
h_{FE}	$V_{CE} = 5\text{ V}$, $I_C = 0.5\text{ A}$	50			
C_{obo}	$V_{CB} = 5\text{ V}$, $I_E = 0$, $f = 0.1\text{ MHz}$	185			pF

NOTES: 2. Inductive loop switching measurement.

3. These parameters must be measured using pulse techniques, $t_W \leq 300\text{ }\mu\text{s}$, duty cycle $\leq 2\%$.

4. These parameters are measured with voltage-sensing contacts separate from the current-carrying contacts located within 3.2 mm (0.125 inch) from the device body.

thermal characteristics

PARAMETER	MIN	TYP	MAX	UNIT
$R_{\theta JC}$			0.97	$^\circ\text{C/W}$

resistive-load switching characteristics at 25°C case temperature (unless otherwise noted)

PARAMETER	TEST CONDITIONS	TIPL773A			UNIT
		MIN	TYP	MAX	
t_{on}	$I_C = 12.5\text{ A}$, $V_{CE} = 250\text{ V}$, $I_{B2} = -1.5\text{ A}$, $T_C = 25^\circ\text{C}$, See Figures 1 and 1c		1.25		μs
t_s			3.5		μs
t_f			1		μs
t_{on}	$I_C = 12.5\text{ A}$, $V_{CE} = 250\text{ V}$, $I_{B2} = -1.5\text{ A}$, $T_C = 100^\circ\text{C}$, See Figures 1 and 1c		2		μs
t_s			5		μs
t_f			2		μs

inductive-load switching characteristics at 25°C case temperature (unless otherwise noted)

PARAMETER	TEST CONDITIONS	TIPL773A			UNIT
		MIN	TYP	MAX	
t_{sv}	$I_C = 12.5\text{ A}$, $V_{CE} = 300\text{ V}$, $I_{B2} = -1.5\text{ A}$, $T_C = 25^\circ\text{C}$, See Figures 1, 1b, and 2		3		μs
t_{rv}			0.5		μs
t_{fl}			0.3		μs
t_{xo}			0.8		μs
t_{tl}			0.1		μs
t_{sv}			5		μs
t_{rv}	$I_C = 12.5\text{ A}$, $V_{CE} = 300\text{ V}$, $I_{B2} = -1.5\text{ A}$, $T_C = 100^\circ\text{C}$, See Figures 1, 1b, and 2		1.5		μs
t_{fl}			0.5		μs
t_{xo}			2		μs
t_{tl}			0.5		μs

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TIPL773B
N-P-N SILICON TRIPLE TRANSISTOR
ADVANCED POWER DARLINGTON

electrical characteristics at 25°C case temperature (unless otherwise noted)

PARAMETER	TEST CONDITIONS	TIPL773B			UNIT
		MIN	TYP	MAX	
$V_{CEX(sus)}$	$I_C = 6\text{ A}$, $I_{B2} = 1\text{ A}$, See Figures 1 and 1a	970			V
$V_{CEO(sus)}$	$I_C = 0.1\text{ A}$, $L = 25\text{ mH}$, See Note 2	800			V
I_{CEO}	$V_{CE} = 800\text{ V}$, $I_B = 0$			50	μA
I_{CES}	$V_{CE} = 1150\text{ V}$, $V_{BE} = 0$			0.1	mA
	$V_{CE} = 1150\text{ V}$, $V_{BE} = 0$, $T_C = 100^\circ\text{C}$			1	
I_{CEV}	$V_{CE} = 1150\text{ V}$, $V_{BE} = -1.5\text{ V to } -6\text{ V}$			0.1	mA
I_{EBO}	$V_{EB} = 6\text{ V}$, $I_C = 0$			10	mA
$V_{CE(sat)}$	$I_C = 1\text{ A}$, $I_B = 20\text{ mA}$, See Notes 3 and 4			2	V
	$I_C = 5\text{ A}$, $I_B = 0.1\text{ A}$, See Notes 3 and 4			2.2	
	$I_C = 10\text{ A}$, $I_B = 0.2\text{ A}$, See Notes 3 and 4			2.5	
	$I_C = 10\text{ A}$, $I_B = 0.2\text{ A}$, $T_C = 100^\circ\text{C}$, See Notes 3 and 4			2.5	
$V_{BE(sat)}$	$I_C = 1\text{ A}$, $I_B = 20\text{ mA}$, See Notes 3 and 4			3	V
	$I_C = 5\text{ A}$, $I_B = 0.1\text{ A}$, See Notes 3 and 4			3.5	
	$I_C = 10\text{ A}$, $I_B = 0.2\text{ A}$, See Notes 3 and 4			4	
	$I_C = 10\text{ A}$, $I_B = 0.2\text{ A}$, $T_C = 100^\circ\text{C}$, See Notes 3 and 4			4	
V_F	$I_F = 15\text{ A}$, See Notes 3 and 4			2	V
h_{FE}	$V_{CE} = 5\text{ V}$, $I_C = 0.5\text{ A}$	50			
C_{obo}	$V_{CB} = 5\text{ V}$, $I_E = 0$, $f = 0.1\text{ MHz}$	185			pF

NOTES: 2. Inductive loop switching measurement.

3. These parameters must be measured using pulse techniques, $t_W \leq 300\text{ }\mu\text{s}$, duty cycle $\leq 2\%$.

4. These parameters are measured with voltage-sensing contacts separate from the current-carrying contacts located within 3.2 mm (0.125 inch) from the device body.

thermal characteristics

PARAMETER	MIN	TYP	MAX	UNIT
$R_{\theta JC}$		0.97		$^\circ\text{C/W}$

resistive-load switching characteristics at 25°C case temperature (unless otherwise noted)

PARAMETER	TEST CONDITIONS	TIPL773B			UNIT
		MIN	TYP	MAX	
t_{on}	$I_C = 10\text{ A}$, $V_{CE} = 250\text{ V}$, $I_{B2} = -1.5\text{ A}$, $T_C = 25^\circ\text{C}$, See Figures 1 and 1c		1.25		μs
t_s			4		μs
t_f			1		μs
t_{on}	$I_C = 10\text{ A}$, $V_{CE} = 250\text{ V}$, $I_{B2} = -1.5\text{ A}$, $T_C = 100^\circ\text{C}$, See Figures 1 and 1c		2		μs
t_s			6		μs
t_f			2		μs

inductive-load switching characteristics at 25°C case temperature (unless otherwise noted)

PARAMETER	TEST CONDITIONS	TIPL773B			UNIT
		MIN	TYP	MAX	
t_{sv}	$I_C = 10\text{ A}$, $V_{CE} = 300\text{ V}$, $I_{B2} = -1.5\text{ A}$, $T_C = 25^\circ\text{C}$, See Figures 1, 1b, and 2		3.2		μs
t_{rv}			0.5		μs
t_{fl}			0.3		μs
t_{xo}			0.8		μs
t_{tl}			0.1		μs
t_{sv}			5.2		μs
t_{rv}	$I_C = 10\text{ A}$, $V_{CE} = 300\text{ V}$, $I_{B2} = -1.5\text{ A}$, $T_C = 100^\circ\text{C}$, See Figures 1, 1b, and 2		1.5		μs
t_{fl}			0.5		μs
t_{xo}			2		μs
t_{tl}			0.15		μs

TIPL Devices



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ADVANCED POWER DARLINGTONS

PARAMETER MEASUREMENT INFORMATION

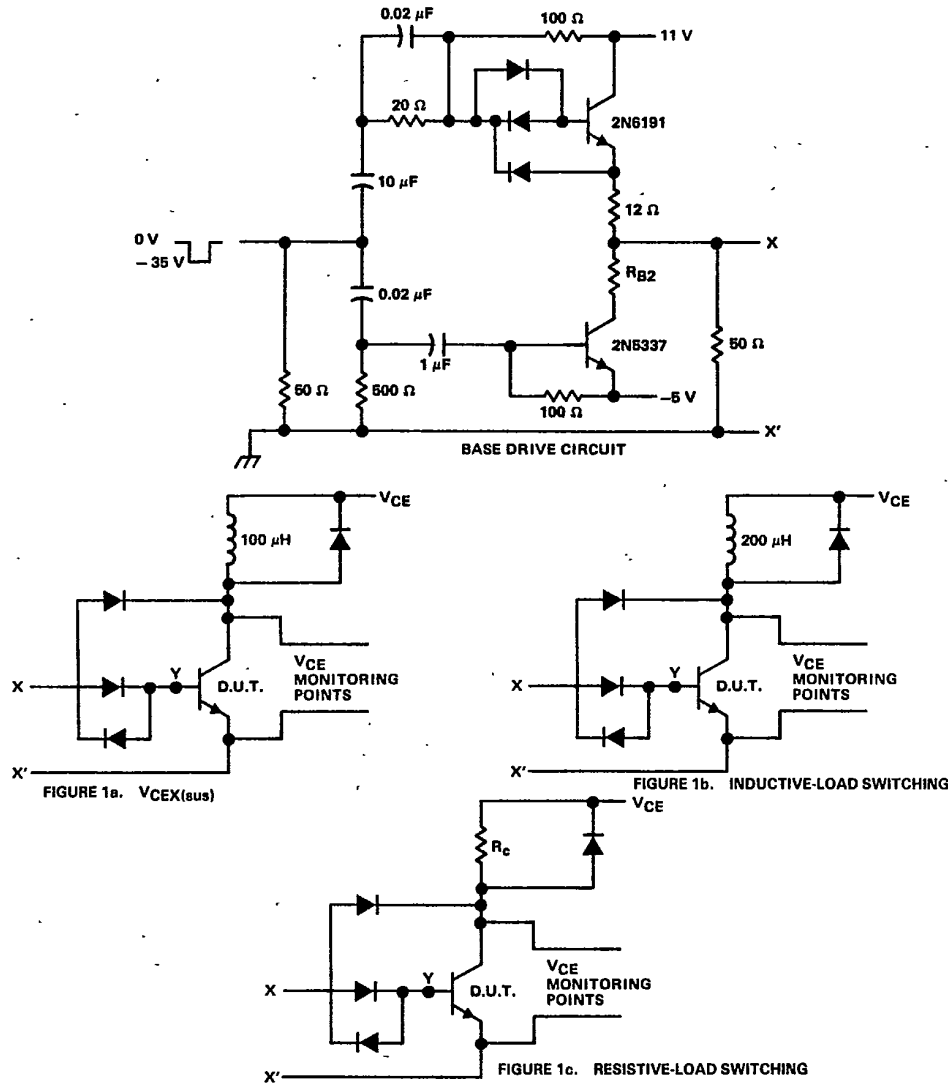


FIGURE 1. SWITCHING TEST CIRCUITS

- NOTES: A. Waveforms are monitored on an oscilloscope with the following characteristics: $t_r \leq 15$ ns, $R_{in} \leq 10$ M Ω , $C_{in} \leq 11.5$ pf.
B. Resistors must be noninductive types.
C. VCE waveforms to be monitored within 3.2 mm (0.125 inch) of the device body.

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N-P-N SILICON TRIPLE TRANSISTOR
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PARAMETER MEASUREMENT INFORMATION

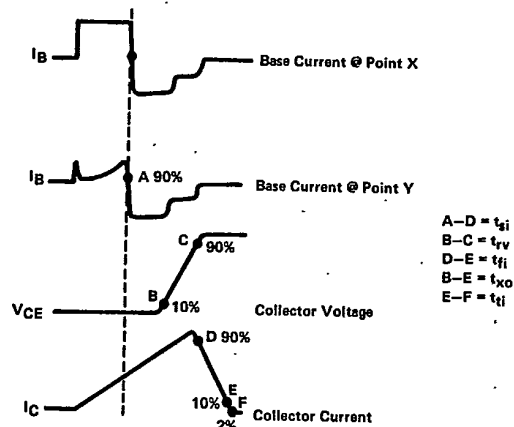


FIGURE 2. INDUCTIVE SWITCHING WAVEFORMS

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ADVANCED POWER DARLINGTONS

TYPICAL CHARACTERISTICS

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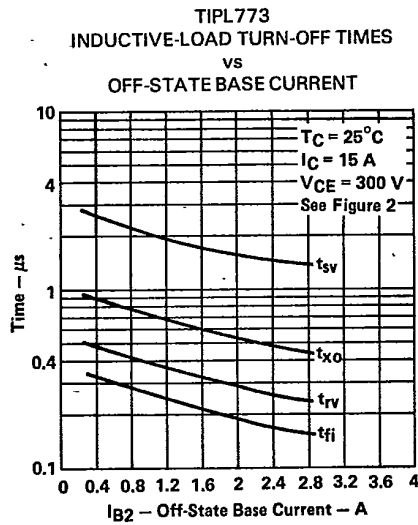


FIGURE 3

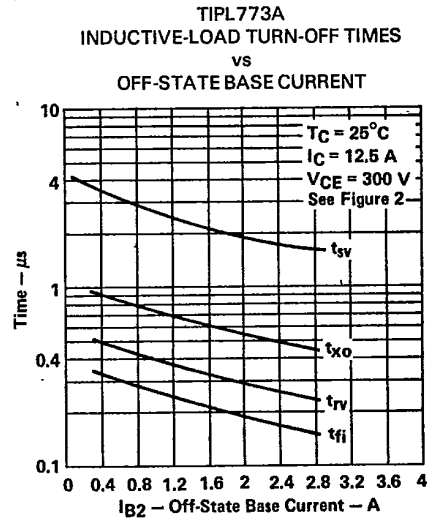


FIGURE 4

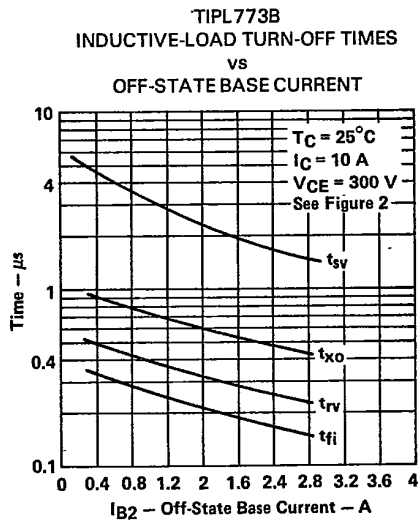


FIGURE 5

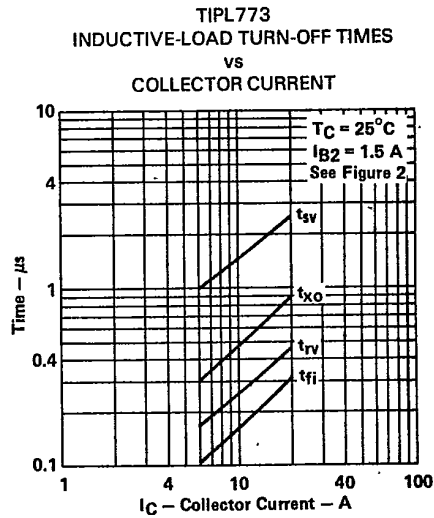


FIGURE 6

TIPL Devices



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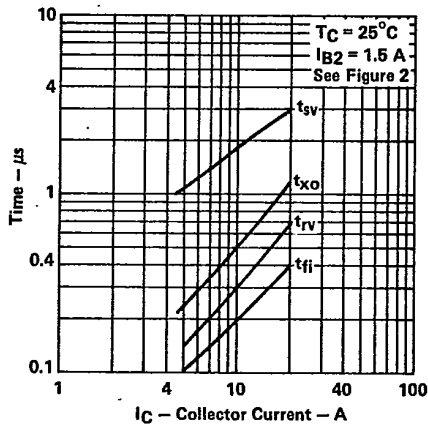
62C 37084 D

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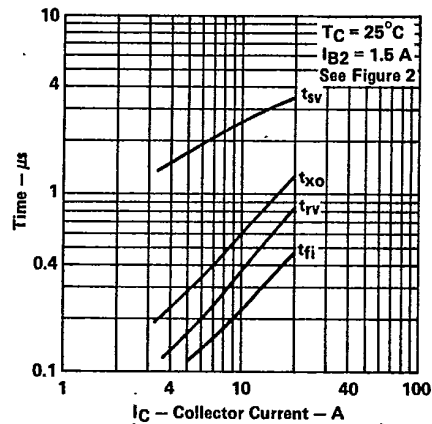
TIPL773, TIPL773A, TIPL773B
N-P-N SILICON TRIPLE TRANSISTOR
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TYPICAL CHARACTERISTICS

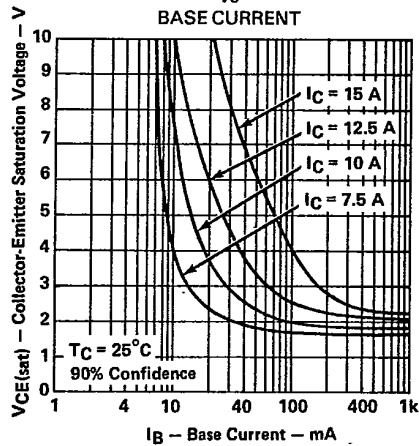
TIPL773A
INDUCTIVE-LOAD TURN-OFF TIME
vs
COLLECTOR CURRENT

**FIGURE 7**

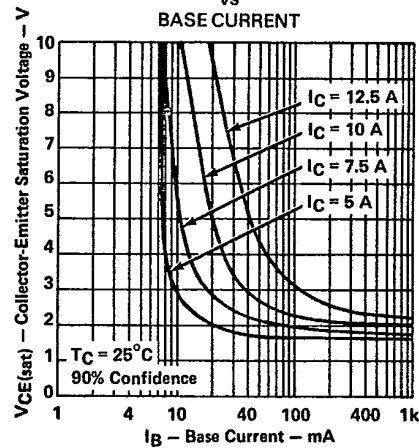
TIPL773B
INDUCTIVE-LOAD TURN-OFF TIME
vs
COLLECTOR CURRENT

**FIGURE 8**

TIPL773
MAXIMUM COLLECTOR-EMITTER
SATURATION VOLTAGE
vs
BASE CURRENT

**FIGURE 9**

TIPL773A
MAXIMUM COLLECTOR-EMITTER
SATURATION VOLTAGE
vs
BASE CURRENT

**FIGURE 10**

TIPL Devices



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TYPICAL CHARACTERISTICS

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TIPL773B
MAXIMUM COLLECTOR-EMITTER
SATURATION VOLTAGE
vs
BASE CURRENT

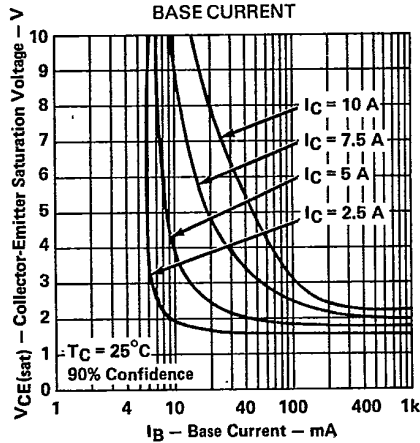


FIGURE 11

TIPL773
BASE-EMITTER SATURATION VOLTAGE
vs
BASE CURRENT

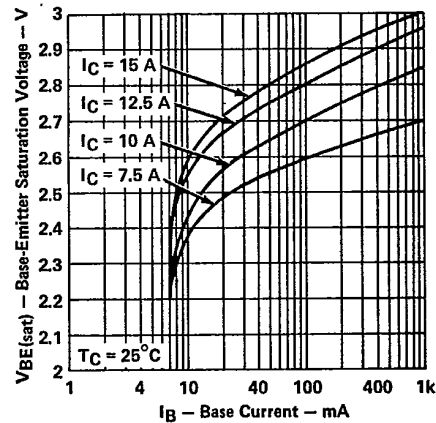


FIGURE 12

TIPL773A
BASE-EMITTER SATURATION VOLTAGE
vs
BASE CURRENT

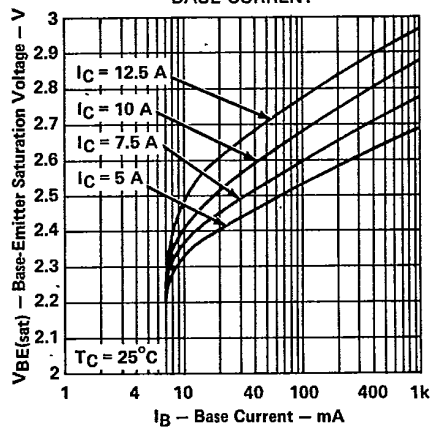


FIGURE 13

TIPL773B
BASE-EMITTER SATURATION VOLTAGE
vs
BASE CURRENT

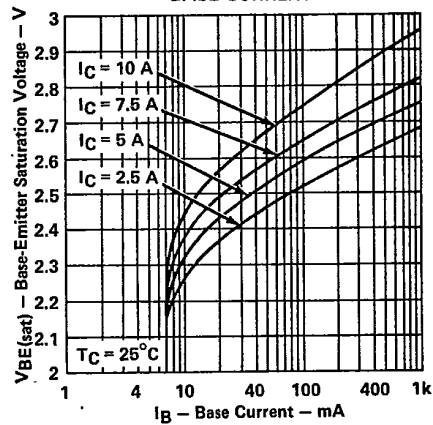


FIGURE 14

TIPL Devices

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N-P-N SILICON TRIPLE TRANSISTOR
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TYPICAL CHARACTERISTICS

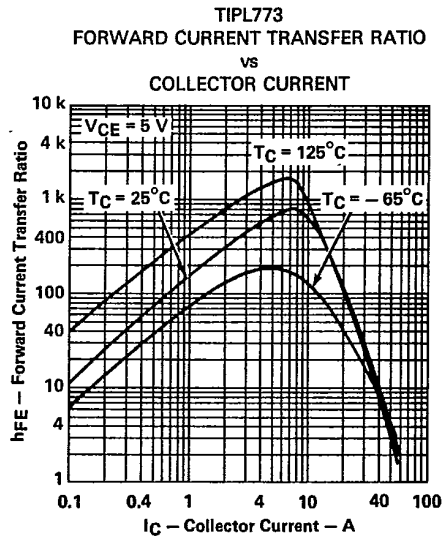


FIGURE 15

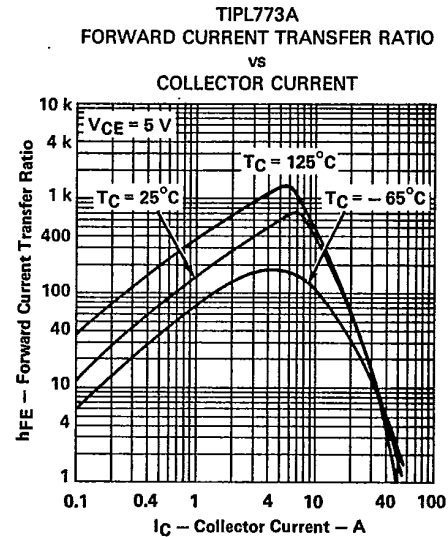


FIGURE 16

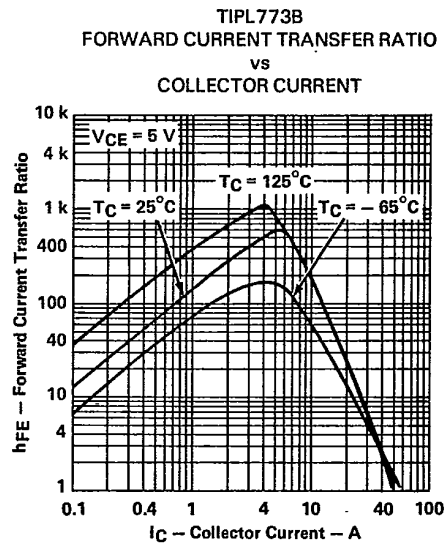


FIGURE 17

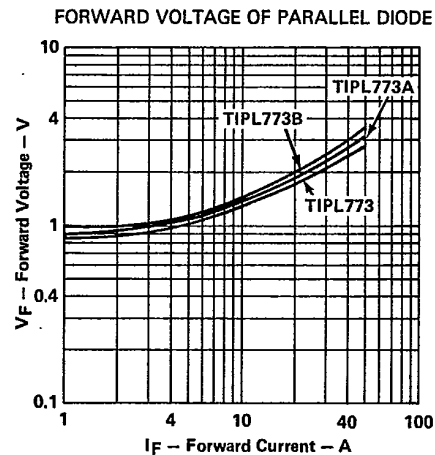


FIGURE 18

TIPL Devices

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N-P-N SILICON TRIPLE TRANSISTOR
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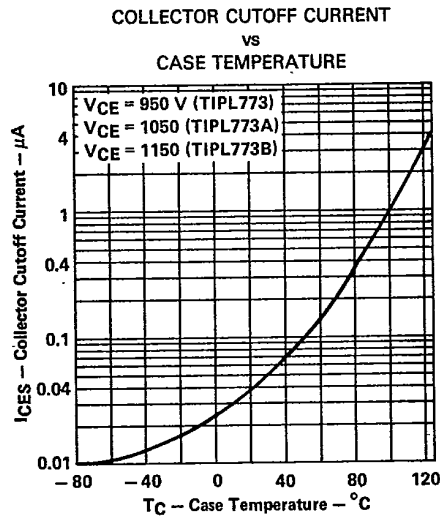


FIGURE 19

MAXIMUM SAFE OPERATING AREA

FORWARD-BIAS SAFE OPERATING AREA

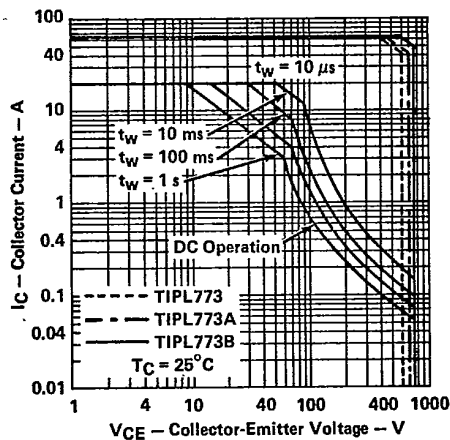


FIGURE 20

REVERSE-BIAS SAFE OPERATING AREA

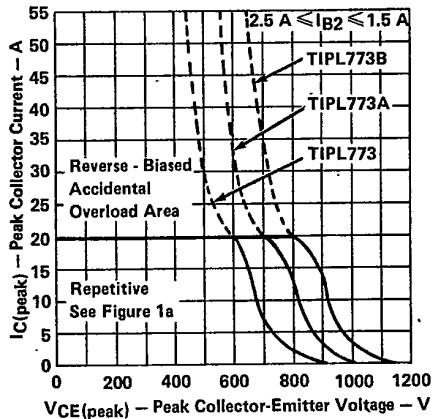


FIGURE 21

TIPL Devices

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62C 37088

D

TIPL773, TIPL773A, TIPL773B
N-P-N SILICON TRIPLE TRANSISTOR
ADVANCED POWER DARLINGTONS

T-33-29

MAXIMUM SAFE OPERATING AREA

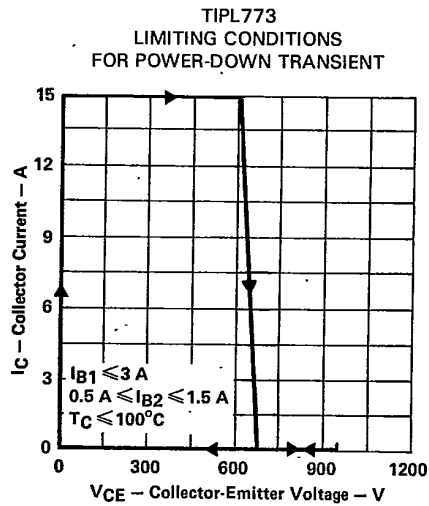


FIGURE 22

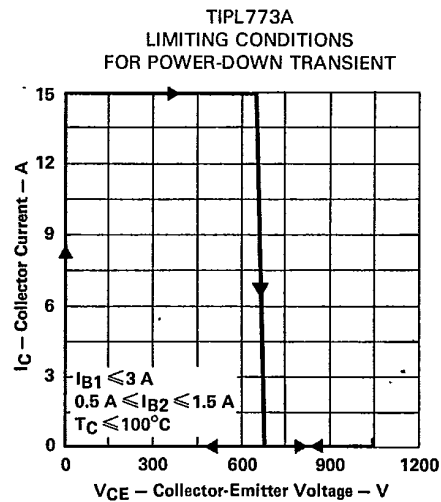


FIGURE 23

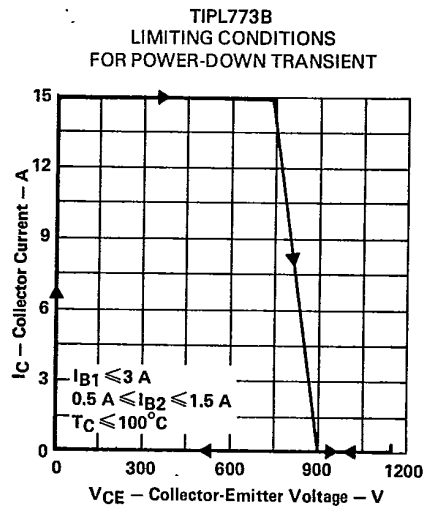


FIGURE 24

TIPL Devices



8961726 TEXAS INSTR (OPTO)

62C 37089 D

TIPL773, TIPL773A, TIPL773B
N-P-N SILICON TRIPLE TRANSISTOR
ADVANCED POWER DARLINGTONS

MAXIMUM SAFE OPERATING AREA

T-33-29

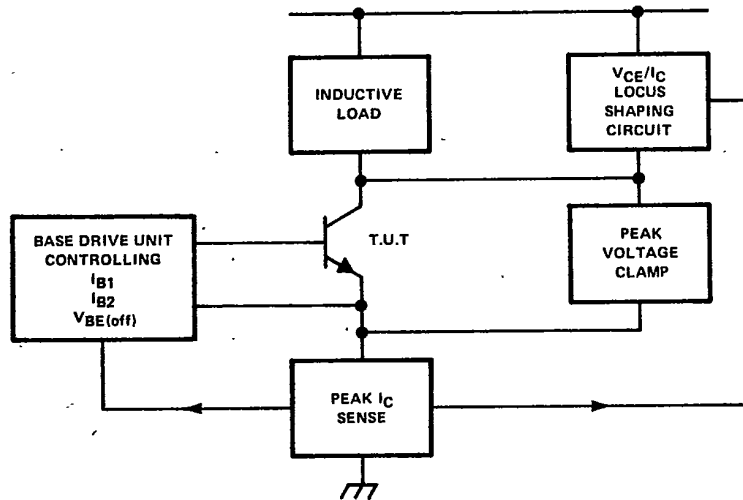


FIGURE 25 TEST CIRCUIT FOR POWER-DOWN TRANSIENT

THERMAL INFORMATION
DISSIPATION DERATING CURVE

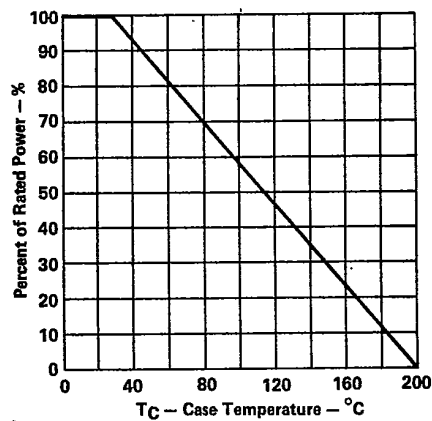


FIGURE 26

TIPL Devices

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